

SPECIFICATION FOR LCD MODULE

MODULE NO: YB-TG32064C01B-N-A0

Doc.Version:01

ustomer Appro	oval:		
☐ Accept			☐ Reject
YEEBO	NAME	SIGNATURE	DATE
Prepare	Electronic Engineer	- July	2017.7.14
Check	Mechanical Engineer	的美加	
Verify		会总制	2015.7.14
Approval		 	2015.714
APPROVAL	L FOR SPECIFICATIONS	SONLY	
APPROVAL	L FOR SPECIFICATIONS	SAND SAMPLE	

WIMRD005-02-D

Add: 7/F.,On Dak Industrial Building,2-6 Wah Sing Street, Kwai Chung,H.K.

Tel: +852-2945-6800; +852-2945-6885

Fax: +852-2481-0019



1. Revision History

Sample Version	DOC. Version	DATE		DESCRIPTION	CHANGED BY
A0	00	2015-03-11	Full spec	First Sample	Shien/Jimmy
A0	01	2015-07-14	Full Spec	Modify LCM drawing Backlight Life Time Interface Pin Assignment Vdd to 3.0V Add initial code	Shien/Jimmy
	1				



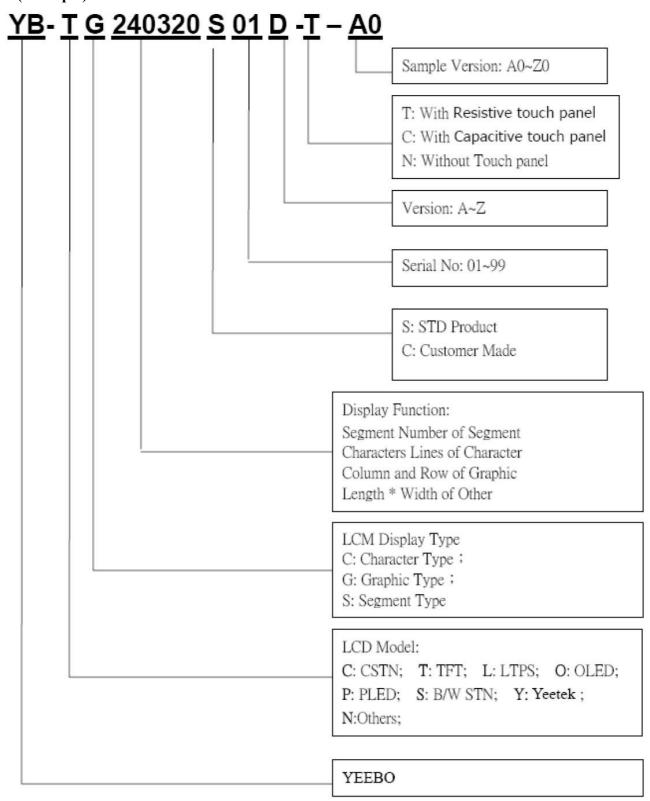
2. Table of Contents:

NO	CONTENTS	PAGE
1	Revision History	1
2	Table of Contents	2
3	Module Numbering System	3
4	General Specification	4
5	LCM drawing	5
6	Electrical Characteristics	6
7	Optical Characteristics	8
8	Interface Pin Assignment	10
9	Block Diagram	11
10	Backlight	12
11	Initial Code	13
12	Standard Specification for Reliability	14
13	Specification of Quality Assurance	16
14	Handing Precaution	25
15	Guarantee	25



3. Module Numbering System:

(Example)



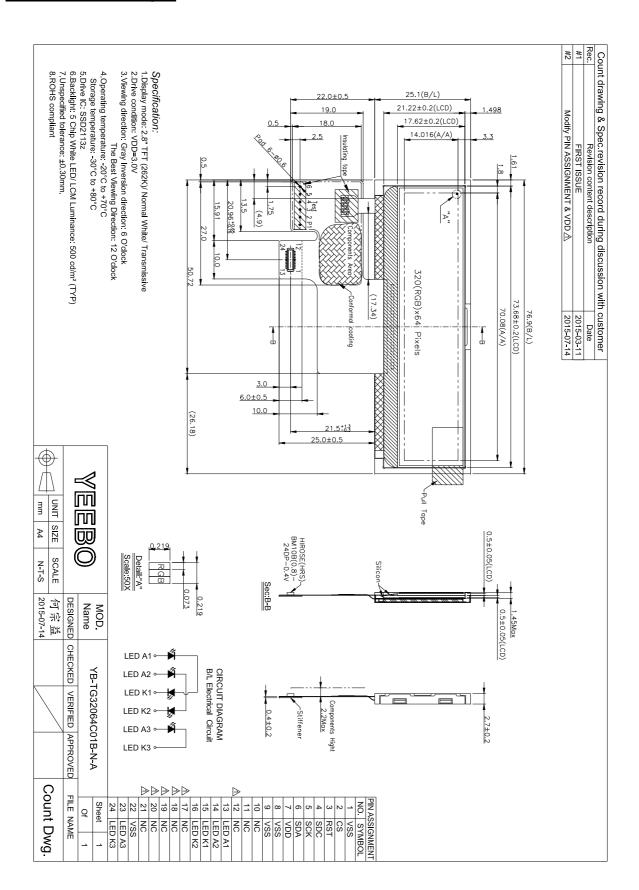


4. General Specification:

ITEM	CONTENTS
Module Size	76.9(W) * 25.1(H) * 2.7(T) mm
Module Size(With FPC)	76.9(W) *50.1 (H) * 2.7(T) mm
Display Size(Diagonal)	2.8 inch
Display Format	320(RGB) * 64 Pixels
Active Area	70.08(W) * 14.016(H) mm
Pixel Pitch	0.219 * 0.219 mm
LCD Type	TFT(262K) / Transmissive/NW
View Angle (Gray inversion)	6 O'clock
The Best View Angle	12 O'clock
Controller IC	SSD2113Z
Weight	9.4g



5. LCM drawing:





6. Electrical Characteristics

6-1 Absolute Maximum Ratings

(Ta=25°C VSS=0V)

Item	Symbol	Min.	Туре	Max.	Unit	Remark
Input Voltage	V_{DD}	-0.3	-	+4.0	Volt	Note1
Operating Temperature	Topr	-20	-	+70	$^{\circ}\!\mathbb{C}$	-
Storage Temperature	Tstg	-30	-	+80	$^{\circ}\!\mathbb{C}$	-

Note1: Absolute maximum rating is the limit value beyond which the IC maybe broken. They do not assure operations.

6-2 Operating Conditions

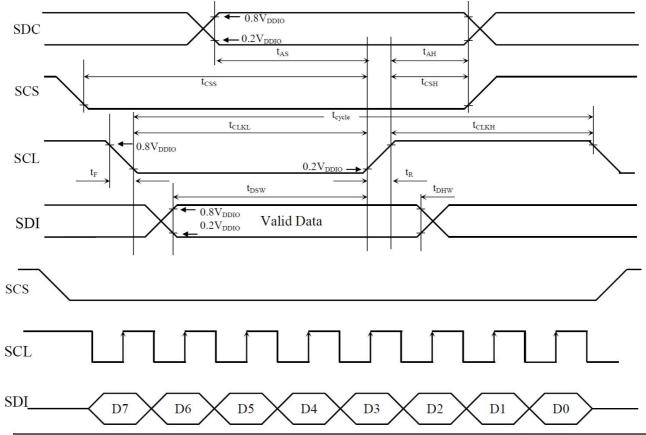
(Ta=25°C)

Item	Symbol	Condition	Min.	Тур.	Max.	Unit
Power Supply voltage1	$V_{ m DD}$	-	2.8	3.0	3.2	Volt
Input Voltage	V_{IH}	-	0.8 * V _{DD}	1	V_{DD}	V
input voitage	$V_{ m IL}$	-	0	-	0.2 * V _{DD}	V
Power Supply Current for LCM	I_{DD}	$V_{DD}=3.0V$	-	6	9	mA
TFT gate on voltage	VGH		10.0		16.0	V
TFT gate off voltage	VGL		-16.0		-9.0	V
TFT common	VCOMH		2.5		5.0	V
electrode voltage	VCOML		-2.5		0	V
Booster voltages	VCIX2	$V_{DD}=3.0V$	-	5.5	-	V

Note: VCIX2 voltage depends on VDD, Initial code has to be modified along with the adjustment of VDD



6-3 Timing Characteristics



Symbol	Parameter	Min	Тур	Max	Unit
t _{cycle}	Clock Cycle Time	66	-	-	ns
f _{CLK}	Serial Clock Cycle Time SPI Clock tolerance = +/- 2 ppm	-		15	MHz
t _{AS}	Register select Setup Time	4	-	-	ns
t _{AH}	Register select Hold Time	5	-	-	ns
t _{CSS}	Chip Select Setup Time	2	-	1-	ns
t _{CSH}	Chip Select Hold Time	10	-	-	ns
t _{DSW}	Write Data Setup Time	5		-	ns
tohw	Write Data Hold Time	10		-	ns
t _{CLKL}	Clock Low Time	33	-	-	ns
t _{CLKH}	Clock High Time	33	-	1-	ns
t _R	Rise time	-	/ -	15	ns
t _F	Fall time	-		15	ns



7. Optical Characteristics:

Itom	tem Symbol Conditions		Symbol Conditions		Specifications			Note	
Iten			Тур	Max	Unit	Note			
Transmit (With		T(%)	1	-	6.0	-	%	-	
			⊕=0						
Contrast	Ratio	CR	Normal	- 800	800 -		(1) (2)		
Contrast	Ratio	CIC	Viewing					(1)(2)	
			angle						
Response	e time	TR+TF	_	-	35	-	ms	(1) (3)	
	Hor.	Θ x+		-	70	-			
Viewin	1101.	Өх-	CR≧10	-	70	-	doa		
g angle	g angle	Өу+	$O_{\rm K} = 10$	-	60	-	deg.	-	
	Ver.	Өу-		-	70	-			

Measuring Condition

1. Measuring surrounding: dark room

2. Ambient temperature: $25\pm2^{\circ}$ C

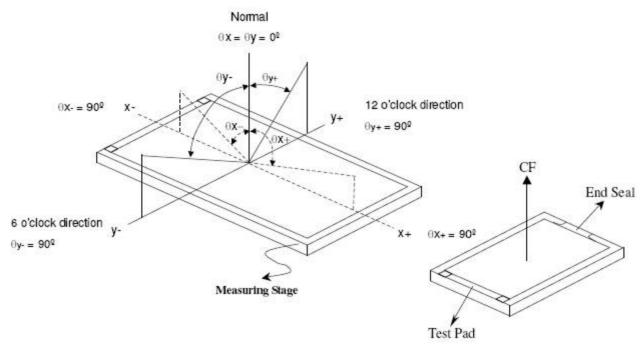
3. 30 min. Warm-up time.

Color of CIE Coordinate:

Item		Symbol	Condition	Min.	Тур.	Max.	Brightness
	D - 1	X		0.592	0.642	0.692	80
	Red	y	$\theta = \phi = 0_{\circ}$	0.282	0.332	0.382	
Chromaticity Coordinates (Transmissive)	Green Blue	X	x Color Degree y X=0.30 y Y=0.30 Brightness	0.253	0.303	0.353	400
		y		0.533	0.583	0.633	400
		X		0.091	0.141	0.191	70
		y		0.088	0.138	0.188	70
	White x y	X	$=8000 \text{cd/m}^2$	0.264	0.314	0.364	500
			0.295	0.345	0.395	500	



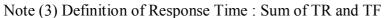
Note (1) Definition of Viewing Angle:

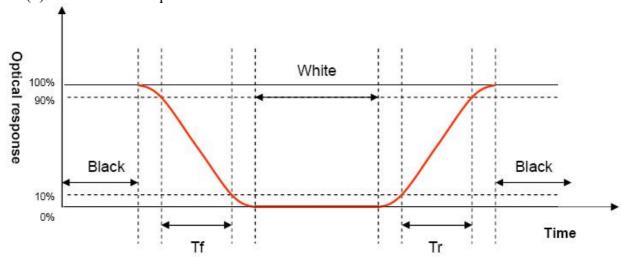


Note (2) Definition of Contrast Ratio(CR): measured at the center point of panel

Contrast ratio (CR)= Photo detector output when LCD is at "White" state

Photo detector output when LCD is at "Black





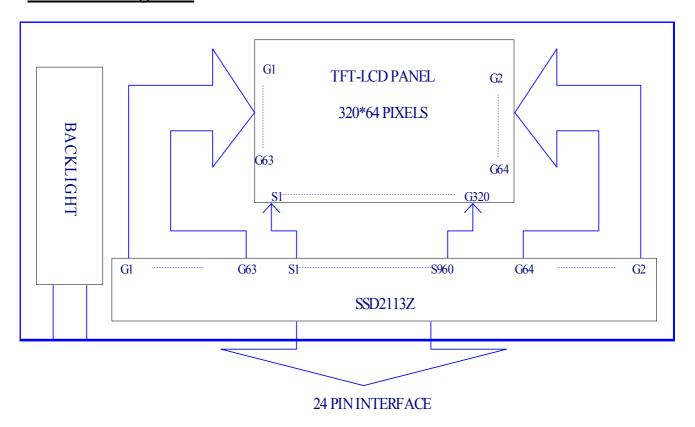


8. Interface Pin Assignment:

No.	Symbol	Function
1	VSS	Ground
2	CS	Chip Select Pin(for SPI bus)
3	RST	Hardware Reset Input Pin
4	SDC	data/register selection for SPI bus
5	SCK	Serial Clock Input
6	SDA	Serial Data input (MOSI)
7	VDD	Supply Voltage
8	VSS	Ground
9	VSS	Ground
10	NC	NC
11	NC	NC
12	NC	NC
13	LEDA1	Anode of LED group 1 and 3
14	LEDA2	Anode of LED group 2 and 4
15	LEDK1	Cathode of LED group 1 and 3
16	LEDK2	Cathode of LED group 2 and 4
17	NC	NC
18	NC	NC
19	NC	NC
20	NC	NC
21	NC	NC
22	VSS	Ground
23	LEDA3	Anode of LED 5
24	LEDK3	Cathode of LED 5



9. Block Diagram:





10. Backlight:

- 1. Standard Lamp Styles (Edge Lighting Type):
 The LED chips are distributed over the edge light area of the illumination unit, which gives the less power consumption:
- 2. The Main Advantages of the LED Backlight are as following:
 - 2.1 The brightness of the backlight can simply be adjusted. By a resistor or a potentiometer.
- 3. Data About LED Backlight:

 $(Ta=25^{\circ}C)$

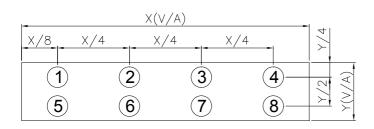
2. 2 www 1 100 ww 222 2 www.mg.w. (1w 25 C							,
PARAMETER	Sym.	Min.	Тур.	Max.	Unit	Test Condition	Note
Supply Current (LED A1-K1)	V	5.6	6.4	6.8	V	I=20mA	
Supply Current (LED A2-K2)	V	5.6	6.4	6.8	V	I=20mA	
Supply Current (LED A3-K3)	V	2.8	3.2	3.4	V	I=20mA	
Reverse VoltageI (Per LED)	Ir	-	ı	0.8	uA	Vr=5.0V	
Luminous Intensity for LCM	LV	400	500	ı	cd/m ²	-	2
Uniformity for LCM	-	70	-	-	%	-	3
Life Time	-	20000	50000	-	Hr.	-	4
Color				V	White		

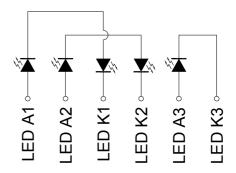
NOTE:

- 1. Backlight Only
- 2. Average Luminous Intensity of P1-P8
- 3. Uniformity = Min/Max * 100%
- 4. LED life time defined as follows: The final brightness is at 50% of original brightness

Measured Method: (X*Y: Light Area)

Internal Circuit Diagram





(Effective spatial Distribution)

Hole Diameter ø3 mm; 1 to 8 per Position Measured Luminous



11.Initial Code(VDD=3.0V):

Commond					
Reg	Data				
28H	0006Н				
00H	0001H				
01H	723FH				
02H	ООООН				
03H	6864H				
10H	ООООН				
D	elay 20mS				
11H	6230H				
07H	0033H				
0CH	0002H				
25H	С000Н				
48H	0000Н				
49H	003FH				
4EH	H0000				
4FH	0000H				
30H	EE0CH				
31H	3199H				
32H	CDC8H				
33H	3011H				
34H	E724H				
35H	18CCH				
36H	6533H				
37H	331CH				
0DH	000CH				
1EH	019CH				
0EH	2C00H				
44H	3F00H				
45H	0000Н				
46H	013FH				
22H					



12. Standard Specification for Reliability: 12–1. Standard Specifications for Reliability of LCD Module

No	Item	Description
01	High temperature operation	The sample should be allowed to stand at 70°C for 120 hours under driving condition and then returning it to normal temperature condition, and allowing it stand for 2 hours.
02	Low temperature operation	The sample should be allowed to stand at -20°C for 120 hours under driving condition and then returning it to normal temperature condition, and allowing it stand for 2 hours.
03	High temperature storage	The sample should be allowed to stand at 80°C for 240 hours under no-load condition, and then returning it to normal temperature condition, and allowing it stand for 2 hours.
04	Low temperature storage	The sample should be allowed to stand at -30°C for 240 hours under no-load condition, then returning it to normal temperature condition, and allowing it stand for 2 hours.
05	Moisture storage	The sample should be allowed to stand at 60°C,90%RH MAX for 240 hours under no-load condition, then taking it out and drying it at normal temperature for 2 hours.
06	Thermal shock storage	The sample should be allowed to stand the following 10 cycles: -30° C for 30 minutes \rightarrow normal temperature for 5 minutes \rightarrow +80°C for 30 minutes \rightarrow normal temperature for 5 minutes, as one cycle.
07	Packing vibration	Frequency range : $10\text{Hz} \sim 55\text{Hz}$ Amplitude of vibration : 1.5mm Sweep time: 12 min X,Y,Z 2 hours for each direction.
08	Packing drop test	According to ISTA 1A 2001.
09	Electrical Static	Air: $\pm 4KV$ 150pF/330 Ω 5 times
	Discharge	Contact: $\pm 2KV \ 150pF/330\Omega \ 5$ time

^{*}Sample size for each test item is 3~5pcs



12 - 2. Testing Conditions and Inspection Criteria

For the final test the testing sample must be stored at room temperature for 24 hours, after the tests listed in Table 12.2, Standard specifications for Reliability have been executed in order to ensure stability.

No	Item	Test Model	In section Criteria
01	Current Consumption	Refer To Specification	The current consumption should conform to the product specification.
02	Contrast	Refer To Specification	After the tests have been executed, the contrast must be larger than half of its initial value prior to the tests.
03	Appearance	Visual inspection	Defect free.

12-3. MTBF

MTBF	Functions, performance, appearance, etc. shall be free from remarkable deterioration within 50,000 hours under ordinary operating and storage conditions room temperature ($25\pm5^{\circ}$ C), normal humidity ($50\pm10\%$ RH), and in area not exposed to direct sun light.
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13. Specification of Quality Assurance:

13-1. Purpose

This standard for Quality Assurance should affirm the quality of LCD module products to supply to purchaser by YEEBO CORPORATION (Supplier).

13-2. Standard for Quality Test

a. Inspection:

Before delivering, the supplier should take the following tests, and affirm the quality of product.

b. Electro-Optical Characteristics:

According to the individual specification to test the product.

c. Test of Appearance Characteristics:

According to the individual specification to test the product.

d. Test of Reliability Characteristics:

According to the definition of reliability on the specification for testing products.

e. Delivery Test:

Before delivering, the supplier should take the delivery test.

- (ii) The defects classify of AQL as following:

Major defect: AQL = 0.65 Minor defect: AQL = 2.5 Total defects: AQL = 2.5

- 13-3. Non- conforming Analysis & Deal With Manners
 - a. Non- conforming Analysis:
 - (i) Purchaser should supply the detail data of non- conforming sample and the non-conforming.
 - (ii) After accepting the detail data from purchaser, the analysis of non- conforming should be finished in two weeks.
 - (iii) If supplier can not finish analysis on time, must announce purchaser before 3 days.
 - b. Disposition of non- conforming:
 - (i) If find any product defect of supplier during assembly time, supplier must change the good product for every defect after recognition.
 - (ii) Both supplier and customer should analyze the reason and discuss the disposition of non-conforming when the reason of nonconforming is not sure.
- 12-4. Agreement items

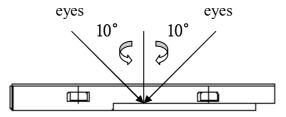
Both sides should discuss together when the following problems happen.

- a. There is any problem of standard of quality assurance, and both sides should think that must be modified.
- b. There is any argument item which does not record in the standard of quality assurance.
- c. Any other special problem.

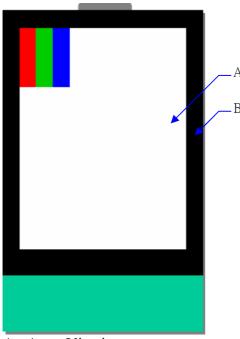


13-5. Standard of The Product Appearance Test

- a. Manner of appearance test:
- (i) The test must be under 20W × 2 or 40W fluorescent light, and the distance of view must be at 30±5cm.
 - (ii) When test the model of transmissive product must add the reflective plate.
 - (iii)The test direction is base on around 10° of vertical line.
 - (iiii)Temperature: 25±5°C Humidity: 60±10%RH



(iv) Definition of area:



- A. Area: Viewing area.
- B. Area: Out of viewing area. (Outside viewing area)

- b. Basic principle:
 - (i) It will accord to the AQL when the standard can not be described.
 - (ii) The sample of the lowest acceptable quality level must be discussed by both supplier and customer when any dispute happened.
 - (iii) Must add new item on time when it is necessary.
 - c. Standard of inspection: (Unit: mm)



13-6. Inspection specification

NO	Item		Cr	iterion		AQL
01	Electrical Testing	 1.1 Missing vertical, horizontal segment, segment contrast defect. 1.2 Missing character, dot or icon. 1.3 Display malfunction. 1.4 No function or no display. 1.5 Current consumption exceeds product specifications. 1.6 LCD viewing angle defect. 1.7 Mixed product types. 1.8 Flicker 			0.65	
02	Black or White spots or Bright spots or Color spots on LCD (Display only)	2.1 White and black orFive spots.2.2 Densely spaced: No	more than	three spots within		2.5
	LCD and Touch Panel black spots,	3.1 Round type: As foll $\Phi = (X+Y)/2$ $X \leftarrow \qquad $	more	Size(mm) $Φ \le 0.10$ $0.10 < Φ \le 0.20$ $0.20 < Φ \le 0.25$ $0.25 < Φ \le 0.30$ 0.30 < Φ than two	Acceptable Q'ty Accept no dense 2 2 1 0 s spots within 3mm.	2.5
03	white spots, contamination (non – display)	3.2 Line type: (As follows) * Dens	Length(mm) L≦3.0 L≦2.5	ing) Width(mm) $W \le 0.02$ $0.02 < W \le 0.05$ $0.03 < W \le 0.08$ $0.08 < W$	Acceptable Q'ty Accept no dense 2 Rejection o lines within 3mm.	2.5



NO	Item	Criterion		AQL
04	Polarizer bubbles	If bubbles are visible, judge using black spot specifications, not easy to find, must check in specify direction $ \begin{array}{c} \text{Size } \Phi(\text{mm}) \\ \Phi \leq 0.20 \\ 0.20 < \Phi \leq 0.50 \\ \hline 0.50 < \Phi \leq 1.00 \\ \hline 1.00 < \Phi \\ \hline \text{Total Q'ty} \\ \end{array} $	Acceptable Q'ty Accept no dense 3 2 0 3	2.5
05	Scratches	Follow NO.3 -2 Line Type.		
06	Chipped glass	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	length 1/8a Peach chip	2.5



NO	Item	Criterion	AQL
		Symbols: x: Chip length y: Chip width z: Chip thickness k: Seal width t: Glass thickness a: LCD side length 7.2 Protrusion over terminal: 7.2.1 Chip on electrode pad:	
		y: Chip width x: Chip length z: Chip thickness	
		$y \le 0.5 \text{mm}$ $x \le 1/8 \text{a}$ $0 < z \le t$ 7.2.2	
07	Glass crack	Non-conductive portion:	2.5
		y: Chip width x: Chip length z: Chip thickness	
		$y \le L \qquad \qquad x \le 1/8a \qquad \qquad 0 < z \le t$	
		 ⊙ If there chipped area touches the ITO terminal, over 2/3 of the ITO must remain and be inspected according to electrode terminal specifications. ⊙ If the product will be heat sealed by the customer, the alignment mark must mot be damaged. 7.2.3 Substrate protuberance and internal crack y: width x: length y≤1/3L X≤a 	



NO	Item	Criterion	AQL
08	Cracked glass	The LCD with extensive crack is not acceptable.	2.5
09	Backlight elements	 9.1 Illumination source flickers when lit. 9.2 Spots or scratches that appear when lit must be judged. Using LCD spot, lines and contamination standards. 9.3 Backlight doesn't light or color is wrong. 	2.5 2.5 0.65
10	Bezel	Bezel must comply with product specifications.	2.5
11	PCB、COB	 11.1 COB seal may not have pinholes larger than 0.2mm or contamination. 11.2 COB seal surface may not have pinholes through to the IC. 11.3 The height of the COB should not exceed the height indicated in the assembly diagram. 11.4 There may not be more than 2mm of sealant outside the seal area on PCB. And there should be no more than three places. 11.5 Parts on PCB must be the same as on the production characteristic chart, There should be no wrong parts, missing parts or excess parts. 11.6 The jumper on the PCB should conform to the product characteristic chart. 	2.5 2.5 2.5 2.5 0.65
12	FPC	12.1 FPC terminal damage $\leq 1/2$ FPC terminal width and can not affect the function, we judge accept. 12.2 FPC alignment hole damage $\leq 1/2$ alignment area and can not affect the function, we judge accept.	2.5
13	Soldering	13.1 No cold solder joints, missing solder connections, oxidation or icicle.13.2 No short circuits in components on PCB or FPC.	2.5 0.65



Symbols: x: Chip length k: Seal width 1: Touch Panel Total thickness k: Seal width 1: Electrode pad length 14.1 General glass chip: 14.1.1 Chip on panel surface and crack between panels: Z: Chip thickness y: Chip width x: Chip length	NO Item	Criterion AQ			AOL
	Touch Panel 14 Chipped	x: Chip length k: Seal width length L: Electrode pad leng 14.1 General glass ch 14.1.1 Chip on panel z: Chip thickness Z≤t	y: Chip width t: Touch Panel Total to gth hip: surface and crack between y: Chip width ≤ 1/2 k and not over	een panels: x: Chip length	
⊙ If there are 2 or more chips, x is the total length of each chip		z: Chip thickness z≤t O Unit: mm	y: Chip width ≤1/2 k and not over viewing area	x: Chip length x≤1/8a	



NO	Item	Criterion	AQL
15	Touch Panel(Fish eye, dent and bubble on film)	$\begin{array}{ c c c }\hline SIZE(mm) & Acceptable Q'ty\\ \hline \Phi \leq 0.2 & Accept no dense\\ \hline 0.2 < D \leq 0.4 & 5\\ \hline 0.4 < D \leq 0.5 & 2\\ \hline 0.5 < D & 0\\ \hline \end{array}$	2.5
16	Touch Panel Newton ring	Newton ring dimension $\leq 1/2$ touch panel area and not affect font and line distortion($\leq 2.5\%$), it is acceptable.	2.5
17	Touch Panel Linearity	Less than 2.5% is acceptable.	2.5
18	LCD Ripple	Touch the touch panel, can not see the LCD ripple. Pen: R 1.0mm silicon rubber. Operation Force: 80g	2.5
19	General appearance	 19.1 Pin type must match type in specification sheet. 19.2 LCD pin loose or missing pins. 19.3 Product packaging must the same as specified on packaging specification sheet. 19.4 Product dimension and structure must conform to product specification sheet. 	0.65 0.65 0.65 0.65
20	Definition of Pixel	Pixel: Group of Three Sub-pixels (Red, Green, Blue): Dot: Red or Green or Blue or Or Dot: Any sub-pixel Bright Dot Defects Dots (sub-pixels) on display which is bright in the picture and visible at	



Black Pattern.

Dark Dot Defects

Dots(sub-pixels) on display which is dark in the picture and visible at Red/Green/Black/White Pattern.

Neighbour Dot Defects

Two or three neighbour dots (dot: sub-pixel) cluster(R&G,G&B,B&R,or R&G&B). Dot Defects Inspection Criteria

NOTE: Dot out of VA can be ignored.

1 to 12 to 2 to the critical shortest				
Items	Inspection Criteria			
	Details	Allowed quantity		
Bright Dot	Not Neighbour Dot	2		
Dark Dot	Not Neighbour Dot	3		
Total acce	5			

[•] Size of dot defect is larger than half of one sub-pixel.



14. Handling Precaution:

14-1 Handling of LCM

- Don't give external shock.
- Don't apply excessive force on the surface.
- Liquid in LCD is hazardous substance. Must not lick and swallow. when the liquid is attach to your hand, skin, cloth etc. Wash it out thoroughly and immediately.
- Don't operate it above the absolute maximum rating.
- Don't disassemble the LCM.
- The operators should be grounded whenever he/she comes into contact with the module. Never touch any of the conductive parts such as the LSI pads,the copper leads on the PCB and the interface terminals with any parts of the human body.
- The modules should be kept in antistatic bags or other containers resistant to static for storage.
- The module is coated with a film to protect the display surface. Be care when peeling off this protective film since static electricity may be generated.

14-2 Storage

- Store in an ambient temperature of 25±10°C, and in a relative humidity of 50±10%RH. Don't expose to sunlight or fluorescent light.
- Storage in a clean environment, free from dust, active gas, and solvent.
- Store in anti-static electricity container.
- Store without any physical load.

14-3 Soldering

- Use only soldering irons with proper grounding and no leakage.
- Iron: No higher than 280±10°C and less than 3 sec during Hand soldering.
- Rewiring: no more than 2 times.

15. Guarantee:

Our products could meet requirements of the environment.

YB's RoHS is introduce European Union Directive 2011/65/EU (ROHS) Requirements and Update.